

Precision, Low-Noise, Rail-to-Rail Output, 36-V, Zero-Drift OPERATIONAL AMPLIFIERS

Check for Samples: [OPA188](#)

FEATURES

- **Low Offset Voltage: 25 μV (max)**
- **Zero-Drift: 0.03 $\mu\text{V}/^\circ\text{C}$**
- **Low Noise: 8.8 $\text{nV}/\sqrt{\text{Hz}}$
0.1-Hz to 10-Hz Noise: 0.25 μV_{PP}**
- **Excellent DC Precision:**
PSRR: 142 dB
CMRR: 146 dB
Open-Loop Gain: 136 dB
- **Gain Bandwidth: 2 MHz**
- **Quiescent Current: 510 μA (max)**
- **Wide Supply Range: $\pm 2\text{ V}$ to $\pm 18\text{ V}$**
- **Rail-to-Rail Output**
- **Input Includes Negative Rail**
- **RFI Filtered Inputs**
- **MicroSIZE Packages**

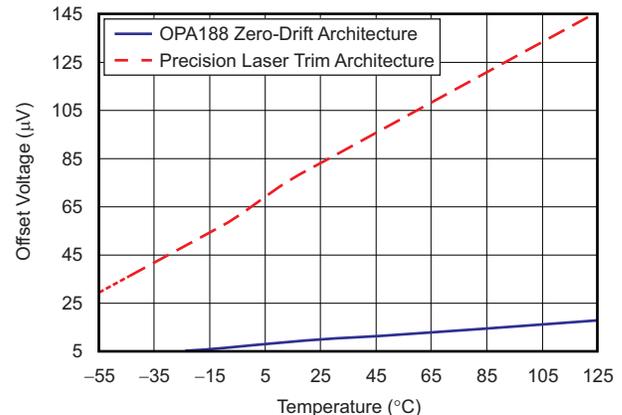
APPLICATIONS

- **Bridge Amplifiers**
- **Strain Gauges**
- **Test Equipment**
- **Transducer Applications**
- **Temperature Measurement**
- **Electronic Scales**
- **Medical Instrumentation**
- **Resistance Temperature Detectors**
- **Precision Active Filters**

DESCRIPTION

The OPA188 operational amplifier uses TI proprietary auto-zeroing techniques to provide low offset voltage (25 μV , max), and near zero-drift over time and temperature. This miniature, high-precision, low quiescent current amplifier offers high input impedance and rail-to-rail output swing within 15 mV of the rails. The input common-mode range includes the negative rail. Either single or dual supplies can be used in the range of +4 V to +36 V ($\pm 2\text{ V}$ to $\pm 18\text{ V}$).

The single version is available in the *MicroSIZE* SOT23-5, MSOP-8, and SO-8 packages. All versions are specified for operation from -40°C to $+125^\circ\text{C}$.


PRODUCT PREVIEW

Zero-Drift Amplifier Portfolio

VERSION	PRODUCT	OFFSET VOLTAGE (μV , max)	OFFSET VOLTAGE DRIFT ($\mu\text{V}/^\circ\text{C}$, max)	BANDWIDTH (MHz)	INPUT VOLTAGE NOISE (μV_{PP} , $f = 0.1\text{ Hz to }10\text{ Hz}$)
Single	OPA188 (4 V to 36 V)	± 25	± 0.085	2	0.25
	OPA333 (5 V)	± 10	± 0.05	0.35	1.1
	OPA378 (5 V)	± 50	± 0.25	0.9	0.4
	OPA735 (12 V)	± 5	± 0.05	1.6	2.5
Dual	OPA2188 (4 V to 36 V)	± 25	± 0.085	2	0.25
	OPA2333 (5 V)	± 10	± 0.05	0.35	1.1
	OPA2378 (5 V)	± 50	± 0.25	0.9	0.4
	OPA2735 (12 V)	± 5	± 0.05	1.6	2.5
Quad	OPA4188 (4 V to 36 V)	± 25	± 0.085	2	0.25
	OPA4330 (5 V)	± 50	± 0.25	0.35	1.1



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

PACKAGE INFORMATION⁽¹⁾

PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
OPA188	SOT23-5	DBV	–40°C to +125°C	QXZ	OPA188AIDBVT	Tape and Reel, 250
					OPA188AIDBVR	Tape and Reel, 3000
	SO-8	D	–40°C to +125°C	OPA188	OPA188AID	Rails, 75
					OPA188AIDR	Tape and Reel, 2500
	MSOP-8	DGK	–40°C to +125°C	QXX	OPA188AIDGKT	Tape and Reel, 250
					OPA188AIDGKR	Tape and Reel, 2500

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at www.ti.com.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

		VALUE	UNIT
Supply voltage		±20, 40 (single supply)	V
Signal input terminals ⁽²⁾	Voltage	(V–) – 0.5 to (V+) + 0.5	V
	Current	±10	mA
	Differential	±0.7	V
Output short-circuit ⁽³⁾		Continuous	
Temperature range	Operating ⁽⁴⁾ , T _A	–55 to +150	°C
	Storage, T _{stg}	–65 to +150	°C
	Junction, T _J	+150	°C
Electrostatic discharge (ESD) ratings	Human body model (HBM)	1.5	kV
	Charged device model (CDM)	1	kV

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and do not imply functional operation of the device at these or any other conditions beyond those indicated. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5 V beyond the supply rails should be current-limited to 10 mA or less.
- (3) Short-circuit to ground.
- (4) Provided device does not exceed maximum junction temperature (T_J) at any time.

**ELECTRICAL CHARACTERISTICS:
High-Voltage Operation, $V_S = \pm 4\text{ V}$ to $\pm 18\text{ V}$ ($V_S = +8\text{ V}$ to $+36\text{ V}$)**

At $T_A = +25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$ ⁽¹⁾, and $V_{CM} = V_{OUT} = V_S / 2$ ⁽¹⁾, unless otherwise noted.

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						
V_{OS}	Input offset voltage			± 6	± 25	μV
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		± 0.03	± 0.085	$\mu\text{V}/^\circ\text{C}$
PSRR	Power-supply rejection ratio	$V_S = 4\text{ V}$ to 36 V , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		± 0.075	± 0.3	$\mu\text{V}/\text{V}$
	Long-term stability ⁽²⁾			4		μV
INPUT BIAS CURRENT						
I_B	Input bias current	$V_{CM} = V_S / 2$		± 160	± 1400	pA
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			± 8	nA
I_{OS}	Input offset current			± 320	± 2800	pA
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			± 4	nA
NOISE						
e_n	Input voltage noise	$f = 0.1\text{ Hz}$ to 10 Hz		250		nV _{PP}
	Input voltage noise	$f = 0.1\text{ Hz}$ to 10 Hz		40		nV _{RMS}
	Input voltage noise density	$f = 1\text{ kHz}$		8.8		nV/ $\sqrt{\text{Hz}}$
i_n	Input current noise density	$f = 1\text{ kHz}$		7		fA/ $\sqrt{\text{Hz}}$
INPUT VOLTAGE RANGE						
V_{CM}	Common-mode voltage range	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	V^-		$(V^+) - 1.5$	V
CMRR	Common-mode rejection ratio	$(V^-) < V_{CM} < (V^+) - 1.5\text{ V}$	120	134		dB
		$(V^-) + 0.5\text{ V} < V_{CM} < (V^+) - 1.5\text{ V}$, $V_S = \pm 18\text{ V}$	130	146		dB
		$(V^-) + 0.5\text{ V} < V_{CM} < (V^+) - 1.5\text{ V}$, $V_S = \pm 18\text{ V}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	120	126		dB
INPUT IMPEDANCE						
	Differential			100 6		M Ω pF
	Common-mode			6 9.5		$10^{12}\ \Omega$ pF
OPEN-LOOP GAIN						
A_{OL}	Open-loop voltage gain	$(V^-) + 0.5\text{ V} < V_O < (V^+) - 0.5\text{ V}$	130	136		dB
		$(V^-) + 0.5\text{ V} < V_O < (V^+) - 0.5\text{ V}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	120	126		dB
FREQUENCY RESPONSE						
GBW	Gain-bandwidth product			2		MHz
SR	Slew rate	$G = +1$		0.8		V/ μs
	Settling time	0.1%	$V_S = \pm 18\text{ V}$, $G = 1$, 10-V step	20		μs
		0.01%	$V_S = \pm 18\text{ V}$, $G = 1$, 10-V step	27		μs
t_{OR}	Overload recovery time	$V_{IN} \times G = V_S$		1		μs
THD+N	Total harmonic distortion + noise	1 kHz, $G = 1$, $V_{OUT} = 1\text{ V}_{rms}$		0.0001		%

(1) $V_S / 2 =$ midsupply.

(2) 1000-hour life test at $+125^\circ\text{C}$ demonstrated randomly distributed variation in the range of measurement limits—approximately $4\ \mu\text{V}$.

ELECTRICAL CHARACTERISTICS:**High-Voltage Operation, $V_S = \pm 4\text{ V}$ to $\pm 18\text{ V}$ ($V_S = +8\text{ V}$ to $+36\text{ V}$) (continued)**

At $T_A = +25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2^{(1)}$, and $V_{CM} = V_{OUT} = V_S / 2^{(1)}$, unless otherwise noted.

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT						
Voltage output swing from rail		No load		6	15	mV
		$R_L = 10\text{ k}\Omega$		220	250	mV
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		310	350	mV
I_{SC} Short-circuit current		Sinking		-18		mA
		Sourcing		+16		mA
R_O Open-loop output resistance		$f = 1\text{ MHz}$, $I_O = 0$		120		Ω
C_{LOAD} Capacitive load drive				1		nF
POWER SUPPLY						
V_S Operating voltage range			4 to 36 (± 2 to ± 18)			V
I_Q Quiescent current (per amplifier)		$V_S = \pm 4\text{ V}$ to $V_S = \pm 18\text{ V}$		450	510	μA
		$I_O = 0\text{ mA}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			540	μA
TEMPERATURE RANGE						
Temperature range	Specified		-40		+125	$^\circ\text{C}$
	Operating		-55		+150	$^\circ\text{C}$
	Storage		-65		+150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS:
Low-Voltage Operation, $V_S = \pm 2\text{ V}$ to $< \pm 4\text{ V}$ ($V_S = +4\text{ V}$ to $< +8\text{ V}$)**

At $T_A = +25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2^{(1)}$, and $V_{CM} = V_{OUT} = V_S / 2^{(1)}$, unless otherwise noted.

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						
V_{OS}	Input offset voltage			± 6	± 25	μV
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		± 0.03	± 0.085	$\mu\text{V}/^\circ\text{C}$
PSRR	Power-supply rejection ratio	$V_S = 4\text{ V}$ to 36 V , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		0.075	0.3	$\mu\text{V}/\text{V}$
	Long-term stability ⁽²⁾			4		μV
INPUT BIAS CURRENT						
I_B	Input bias current			± 160	± 1400	pA
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			± 8	nA
I_{OS}	Input offset current			± 320	± 2800	pA
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			± 4	nA
NOISE						
e_n	Input voltage noise	$f = 0.1\text{ Hz}$ to 10 Hz		250		nV_{PP}
	Input voltage noise	$f = 0.1\text{ Hz}$ to 10 Hz		40		nV_{RMS}
	Input voltage noise density	$f = 1\text{ kHz}$		8.8		$\text{nV}/\sqrt{\text{Hz}}$
i_n	Input current noise density	$f = 1\text{ kHz}$		7		$\text{fA}/\sqrt{\text{Hz}}$
INPUT VOLTAGE RANGE						
V_{CM}	Common-mode voltage range	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	V^-		$(V^+) - 1.5$	V
CMRR	Common-mode rejection ratio	$(V^-) < V_{CM} < (V^+) - 1.5\text{ V}$	106	114		dB
		$(V^-) + 0.5\text{ V} < V_{CM} < (V^+) - 1.5\text{ V}$, $V_S = \pm 2\text{ V}$	114	120		dB
		$(V^-) + 0.5\text{ V} < V_{CM} < (V^+) - 1.5\text{ V}$, $V_S = \pm 2\text{ V}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	110	120		dB
INPUT IMPEDANCE						
	Differential			$100 \parallel 6$		$\text{M}\Omega \parallel \text{pF}$
	Common-mode			$6 \parallel 95$		$10^{12}\ \Omega \parallel \text{pF}$
OPEN-LOOP GAIN						
A_{OL}	Open-loop voltage gain	$(V^-) + 0.5\text{ V} < V_O < (V^+) - 0.5\text{ V}$, $R_L = 5\text{ k}\Omega$	110	120		dB
		$(V^-) + 0.5\text{ V} < V_O < (V^+) - 0.5\text{ V}$	120	130		dB
		$(V^-) + 0.5\text{ V} < V_O < (V^+) - 0.5\text{ V}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	110	120		dB
FREQUENCY RESPONSE						
GBW	Gain-bandwidth product			2		MHz
SR	Slew rate	$G = +1$		0.8		$\text{V}/\mu\text{s}$
t_{OR}	Overload recovery time	$V_{IN} \times G = V_S$		1		μs
THD+N	Total harmonic distortion + noise	1 kHz, $G = 1$, $V_{OUT} = 1\text{ V}_{rms}$		0.0001		$\%$

(1) $V_S / 2 = \text{midsupply}$.

(2) 1000-hour life test at $+125^\circ\text{C}$ demonstrated randomly distributed variation in the range of measurement limits—approximately $4\ \mu\text{V}$.

ELECTRICAL CHARACTERISTICS:**Low-Voltage Operation, $V_S = \pm 2\text{ V}$ to $< \pm 4\text{ V}$ ($V_S = +4\text{ V}$ to $< +8\text{ V}$) (continued)**

At $T_A = +25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2^{(1)}$, and $V_{CM} = V_{OUT} = V_S / 2^{(1)}$, unless otherwise noted.

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT						
Voltage output swing from rail	No load			6	15	mV
	$R_L = 10\text{ k}\Omega$			220	250	mV
	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			310	350	mV
I_{SC}	Short-circuit current	Sinking		-18		mA
		Sourcing		+16		mA
R_O	Open-loop output resistance	$f = 1\text{ MHz}$, $I_O = 0$		120		Ω
C_{LOAD}	Capacitive load drive			1		nF
POWER SUPPLY						
V_S	Operating voltage range		4 to 36 (± 2 to ± 18)			V
I_Q	Quiescent current (per amplifier)	$V_S = \pm 2\text{ V}$ to $V_S = \pm 4\text{ V}$		425	480	μA
		$I_O = 0\text{ mA}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			525	μA
TEMPERATURE RANGE						
Temperature range	Specified		-40		+125	$^\circ\text{C}$
	Operating		-55		+150	$^\circ\text{C}$
	Storage		-65		+150	$^\circ\text{C}$

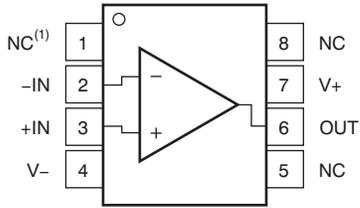
THERMAL INFORMATION

THERMAL METRIC ⁽¹⁾		OPA188			UNITS
		D (SO)	DGK (MSOP)	DBV (SOT23)	
		8 PINS	8 PINS	5 PINS	
θ_{JA}	Junction-to-ambient thermal resistance	TBD	TBD	TBD	$^\circ\text{C}/\text{W}$
θ_{JCTop}	Junction-to-case (top) thermal resistance	TBD	TBD	TBD	
θ_{JB}	Junction-to-board thermal resistance	TBD	TBD	TBD	
ψ_{JT}	Junction-to-top characterization parameter	TBD	TBD	TBD	
ψ_{JB}	Junction-to-board characterization parameter	TBD	TBD	TBD	
θ_{JCbott}	Junction-to-case (bottom) thermal resistance	TBD	TBD	TBD	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

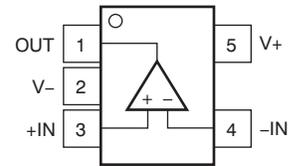
PIN CONFIGURATIONS

**OPA188
D, DGK PACKAGES (SO-8, MSOP-8)
(TOP VIEW)**



(1) NC = no connection.

**OPA188
DBV PACKAGE (SOT23-5)
(TOP VIEW)**



PRODUCT PREVIEW

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
OPA188AID	PREVIEW	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA188	
OPA188AIDBVR	PREVIEW	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-40 to 125	QXZ	
OPA188AIDBVT	PREVIEW	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-40 to 125	QXZ	
OPA188AIDGKR	PREVIEW	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXX	
OPA188AIDGKT	PREVIEW	VSSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXX	
OPA188AIDR	PREVIEW	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA188	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Only one of markings shown within the brackets will appear on the physical device.

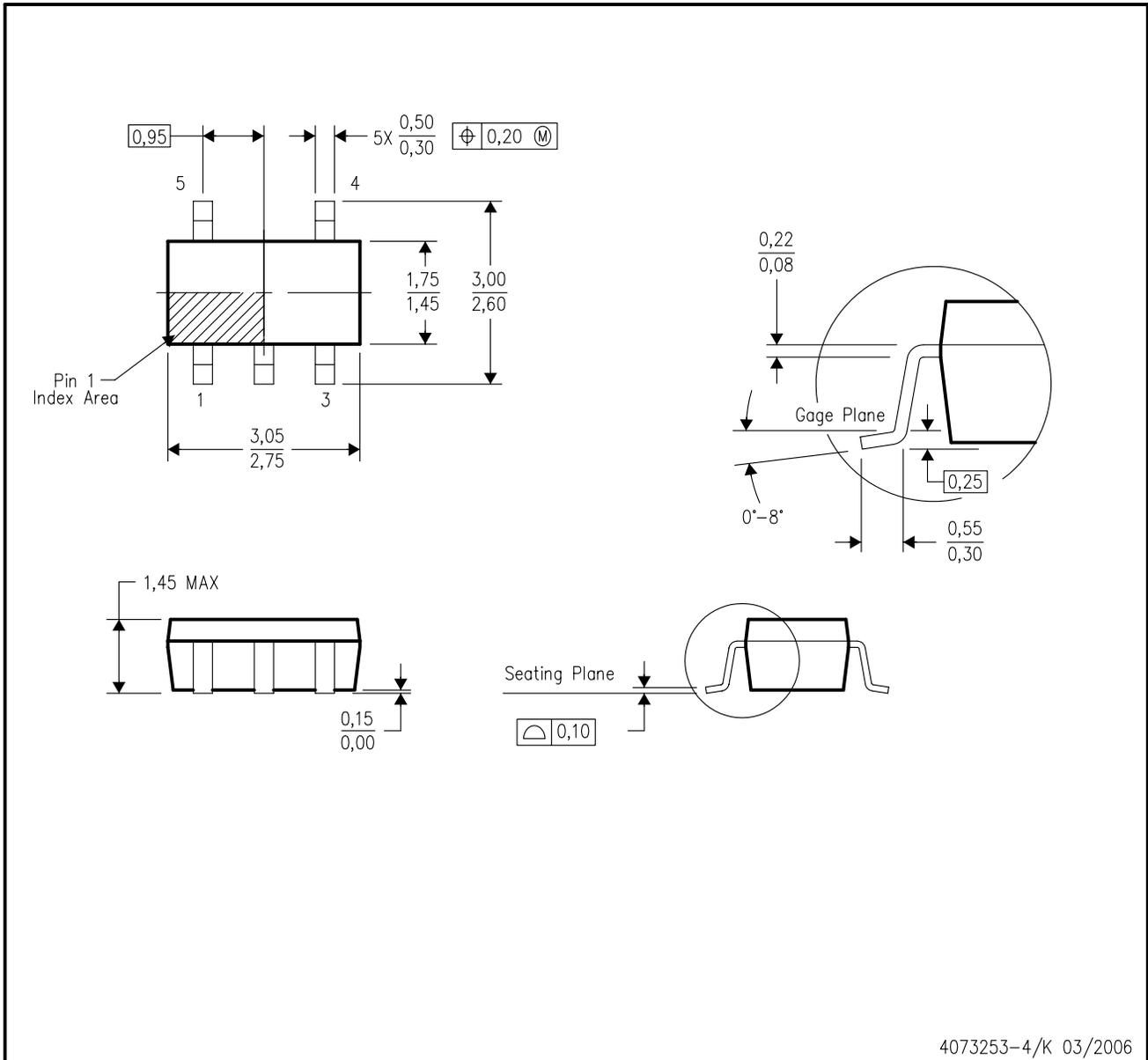
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DBV (R-PDSO-G5)

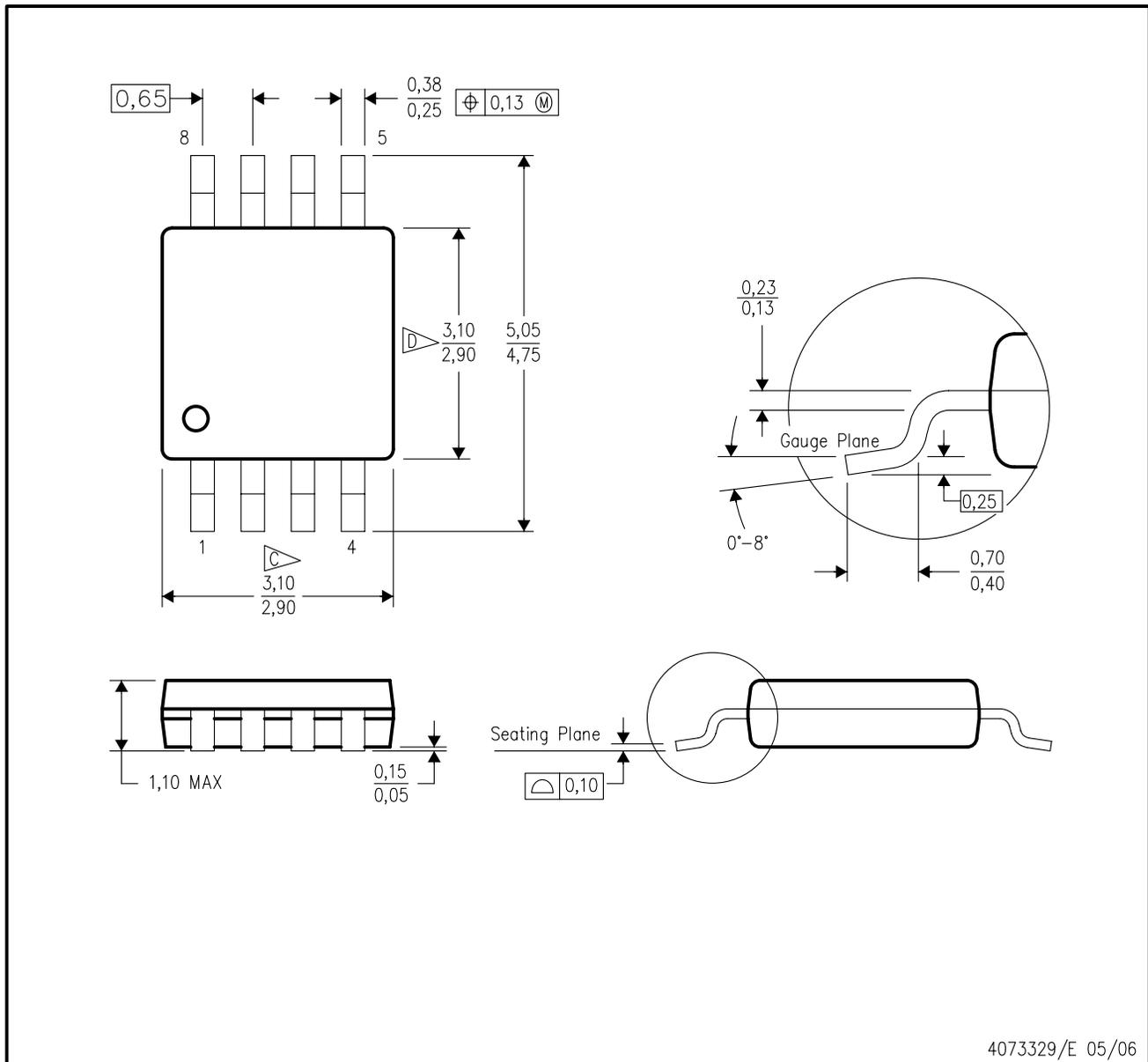
PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. Falls within JEDEC MO-178 Variation AA.

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE

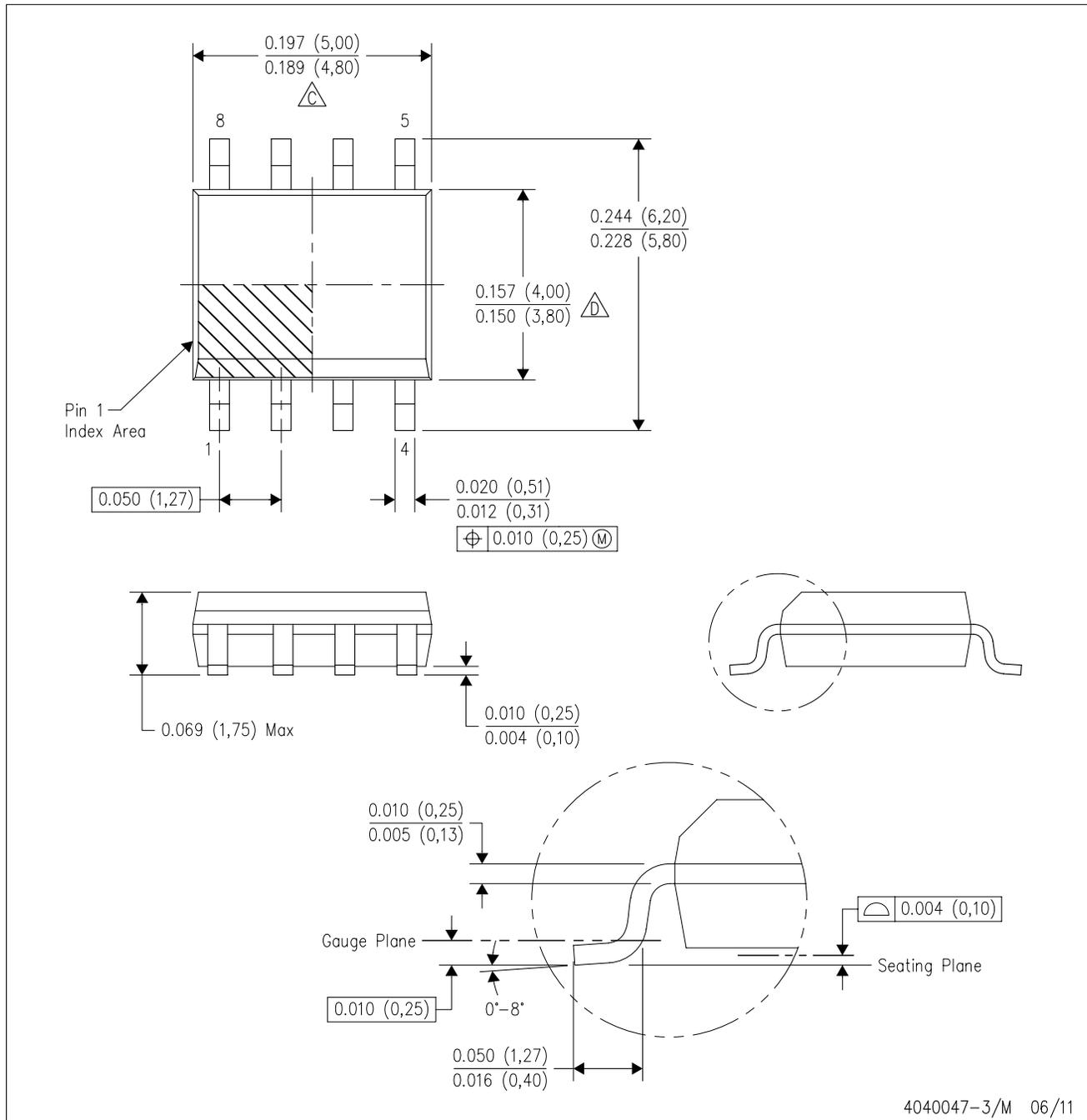


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- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
 - E. Falls within JEDEC MO-187 variation AA, except interlead flash.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AA.

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